Notice of References Cited Application/Control No. 10/567,686 Examiner Thomas R. Hannon Applicant(s)/Patent Under Reexamination SHIBAHARA ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,493,181	12-2002	Ichiyama, Yoshikazu	384/123
*	В	US-6,271,612	08-2001	Tanaka et al.	384/107
	U	US-			
	D	US-			
	Ш	US-			
	F	US-			
	O	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 2003184868 A	07-2003	Japan	IMAE, MASAHARU	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.